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### **FDC6327C**

### Dual N & P-Channel 2.5V Specified PowerTrench™ MOSFET

### **General Description**

These N & P-Channel 2.5V specified MOSFETs are produced using Fairchild Semiconductor's advanced PowerTrench process that has been especially tailored to minimize on-state resistance and yet maintain low gate charge for superior switching performance.

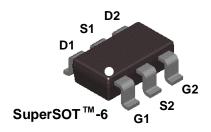
These devices have been designed to offer exceptional power dissipation in a very small footprint for applications where the bigger more expensive SO-8 and TSSOP-8 packages are impractical.

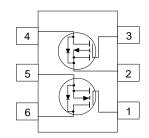
### **Applications**

- DC/DC converter
- · Load switch
- Motor driving

#### **Features**

- N-Channel 2.7A, 20V.  $R_{DS(on)} = 0.08\Omega$  @  $V_{GS} = 4.5V$   $R_{DS(on)} = 0.12\Omega$  @  $V_{GS} = 2.5V$
- P-Channel -1.6A, -20V.R<sub>DS(on)</sub> = 0.17 $\Omega$  @ V<sub>GS</sub> = -4.5V  $R_{DS(on)} = 0.25\Omega$  @ V<sub>GS</sub> = -2.5V
- Fast switching speed.
- · Low gate charge.
- $\bullet$  High performance trench technology for extremely low  $R_{\mbox{\tiny DS(ON)}}.$
- SuperSOT<sup>™</sup>-6 package: small footprint (72% smaller than SO-8); low profile (1mm thick).





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### Absolute Maximum Ratings T<sub>A</sub> = 25°C unless otherwise noted

| Symbol                            | Parameter  |           | N-Channel  | P-Channel  | Units |
|-----------------------------------|--|-----------|------------|------------|-------|
| V <sub>DSS</sub>                  | Drain-Source Voltage                             |           | 20         | -20        | V     |
| V <sub>GSS</sub>                  | Gate-Source Voltage                              |           | <u>±</u> 8 | <u>+</u> 8 | V     |
| I <sub>D</sub>                    | Drain Current - Continuous                       | (Note 1a) | 2.7        | -1.9       | Α     |
|                                   | - Pulsed   |           | 8          | -8         |       |
| P <sub>D</sub>                    | Power Dissipation                                | (Note 1a) | 0.9        | 96         | W     |
|                                   |  | (Note 1b) | 0          | 9          | 1     |
|                                   |  | (Note 1c) | 0          | .7         | 1     |
| T <sub>J</sub> , T <sub>stg</sub> | Operating and Storage Junction Temperature Range |           | -55 to     | +150       | ∘C    |
| Therma                            | I Characteristics                                |           |            |            |       |
| $R_{\theta^{JA}}$                 | Thermal Resistance, Junction-to-Ambient          | (Note 1a) | 13         | 30         | °C/W  |

Package Marking and Ordering Information

Thermal Resistance, Junction-to-Case

| T ackage marking and Ordering information |          |           |            |          |  |  |  |
|---|----------|-----------|------------|----------|--|--|--|
| Device Marking                            | Device   | Reel Size | Tape Width | Quantity |  |  |  |
| .327                                      | FDC6327C | 7"        | 8mm        | 3000     |  |  |  |

(Note 1)

 $\mathsf{R}_{\theta^{\mathsf{JC}}}$ 

°C/W

| Symbol                            | Parameter   | Test Conditions  | Type                                 | Min         | Тур  | Max  | Units |
|-----------------------------------|---|--|--------------------------------------|-------------|--|--|-------|
| Off Cha                           | racteristics                                      |  |                                      |             |  |  |       |
| BV <sub>DSS</sub>                 | Drain-Source Breakdown<br>Voltage                 | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$<br>$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$  | N-Ch<br>P-Ch                         | 20<br>-20   |  |  | V     |
| <u>A</u> BVnss<br>ΔT <sub>J</sub> | Breakdown Voltage<br>Temperature Coefficient      | $I_D = 250 \mu A$ , Referenced to 25°C<br>$I_D = -250 \mu A$ , Referenced to 25°C  | N-Ch<br>P-Ch                         |             | 12<br>-19  |  | mV/∘C |
| I <sub>DSS</sub>                  | Zero Gate Voltage Drain<br>Current                | $V_{DS} = 16 \text{ V}, V_{GS} = 0 \text{ V}$<br>$V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$  | N-Ch<br>P-Ch                         |             |  | 1<br>-1                                      | μΑ    |
| $I_{GSSF}$                        | Gate-Body Leakage, Forward                        | $V_{GS} = 8 \text{ V}, V_{DS} = 0 \text{ V}$   | All                                  |             |  | 100  | nA    |
| I <sub>GSSR</sub>                 | Gate-Body Leakage, Reverse                        | V <sub>GS</sub> = -8 V, V <sub>DS</sub> = 0 V  | All                                  |             |  | -100   | nA    |
| V <sub>GS(th)</sub>               | Gate Threshold Voltage                            | $V_{DS} = V_{GS}, I_D = 250 \mu\text{A}$   | N-Ch                                 | 0.4         | 0.9  | 1.5  | V     |
|                                   |   | $V_{DS} = V_{GS}, I_{D} = -250^{\circ} \mu A$  | N-Ch<br>P-Ch                         | 0.4<br>-0.4 | 0.9<br>-0.9  | 1.5<br>-1.5                                  | _     |
| ΔVGS(th)<br>ΔTJ                   | Gate Threshold Voltage<br>Temperature Coefficient | $I_D$ = 250 $\mu$ A, Referenced to 25°C $I_D$ = -250 $\mu$ A, Referenced to 25°C   | N-Ch<br>P-Ch                         |             | -2.1<br>2.3  |  | mV/°C |
| R <sub>DS(on)</sub>               | Static Drain-Source On-Resistance                 | $\begin{split} &V_{GS} = 4.5 \text{ V}, \ I_D = 2.7 \text{ A} \\ &V_{GS} = 4.5 \text{ V}, \ I_D = 2.7 \text{ A}, \ T_J = 125 ^{\circ}\text{C} \\ &V_{GS} = 2.5 \text{ V}, \ I_D = 2.2 \text{ A} \\ &V_{GS} = -4.5 \text{ V}, \ I_D = -1.6 \text{ A} \\ &V_{GS} = -4.5 \text{ V}, \ I_D = -1.6 \text{ A}, \ T_J = 125 ^{\circ}\text{C} \\ &V_{GS} = -2.5 \text{ V}, \ I_D = -1.3 \text{ A} \end{split}$ | N-Ch<br>N-Ch<br>N-Ch<br>P-Ch<br>P-Ch |             | 0.069<br>0.094<br>0.093<br>0.141<br>0.203<br>0.205 | 0.08<br>0.13<br>0.12<br>0.17<br>0.27<br>0.25 | Ω     |
| $I_{D(on)}$                       | On-State Drain Current                            | $V_{GS} = 4.5 \text{ V}, V_{DS} = 5 \text{ V}$<br>$V_{GS} = -4.5 \text{ V}, V_{DS} = -5 \text{ V}$   | N-Ch<br>P-Ch                         | 8<br>-8     |  |  | Α     |
| <b>g</b> FS                       | Forward Transconductance                          | $V_{DS} = 5 \text{ V}, I_D = 2.7 \text{ A}$<br>$V_{DS} = -5 \text{ V}, I_D = -1.9 \text{ A}$   | N-Ch<br>P-Ch                         |             | 7.7<br>4.5   |  | S     |
| Dynami                            | c Characteristics                                 |  |                                      |             |  |  |       |
| C <sub>iss</sub>                  | Input Capacitance                                 | N-Channel<br>V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1.0 MHz  | N-Ch<br>P-Ch                         |             | 325<br>315   |  | pF    |
| C <sub>oss</sub>                  | Output Capacitance                                | P-Channel  | N-Ch<br>P-Ch                         |             | 75<br>65   |  | pF    |
| C <sub>rss</sub>                  | Reverse Transfer Capacitance                      | $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1.0 \text{ MHz}$   | N-Ch<br>P-Ch                         |             | 35<br>24   |  | pF    |

| Electrical Characteristics | (continued) | T <sub>A</sub> = 25°C unless otherwise noted |
|----------------------------|-------------|--|
|                            |             |  |

| Symbol              | Parameter                          | Test Conditions   | Туре         | Min | Typ          | Max        | Units |  |  |
|---------------------|------------------------------------|---|--------------|-----|--------------|------------|-------|--|--|
| Switchir            | Switching Characteristics (Note 2) |   |              |     |              |            |       |  |  |
| t <sub>d(on)</sub>  | Turn-On Delay Time                 | N-Channel $V_{DD} = 10 \text{ V}, I_D = 1 \text{ A},$                           | N-Ch<br>P-Ch |     | 5<br>7       | 15<br>14   | ns    |  |  |
| t <sub>r</sub>      | Turn-On Rise Time                  | $V_{GS} = 4.5V$ , $R_{GEN} = 6 \Omega$  | N-Ch<br>P-Ch |     | 9<br>14      | 18<br>25   | ns    |  |  |
| $t_{\text{d(off)}}$ | Turn-Off Delay Time                | P-Channel $V_{DD} = -10 \text{ V}, I_D = -1 \text{ A},$                         | N-Ch<br>P-Ch |     | 12<br>14     | 22<br>25   | ns    |  |  |
| t <sub>f</sub>      | Turn-Off Fall Time                 | $V_{GS} = -4.5 \text{ V}, R_{GEN} = 6 \Omega$                                   | N-Ch<br>P-Ch |     | 3<br>3       | 9<br>9     | ns    |  |  |
| Q <sub>g</sub>      | Total Gate Charge                  | N-Channel $V_{DS} = 10 \text{ V}, I_{D} = 2.7 \text{ A}, V_{GS} = 4.5 \text{V}$ | N-Ch<br>P-Ch |     | 3.25<br>2.85 | 4.5<br>4.0 | nC    |  |  |
| $Q_{gs}$            | Gate-Source Charge                 | P-Channel   | N-Ch<br>P-Ch |     | 0.65<br>0.68 |            | nC    |  |  |
| $Q_{gd}$            | Gate-Drain Charge                  | $V_{DS} = -10 \text{ V}, I_{D} = -1.9 \text{ A}, V_{GS} = -4.5 \text{V}$        | N-Ch<br>P-Ch |     | 0.90<br>0.65 |            | nC    |  |  |

**Drain-Source Diode Characteristics and Maximum Ratings** 

| <u> </u> | Prairi Coaro Prode Criaractoriotico aria maximani ratirigo                      |      |       |      |   |  |
|----------|---|------|-------|------|---|--|
| Is       | Maximum Continuous Drain-Source Diode Forward Current                           | N-Ch |       | 0.8  | Α |  |
|          |   | P-Ch |       | -0.8 |   |  |
| $V_{SD}$ | Drain-Source Diode Forward $V_{GS} = 0 \text{ V}, I_S = 0.8 \text{ A}$ (Note 2) | N-Ch | 0.76  | 1.2  | V |  |
|          | Voltage $V_{GS} = 0 \text{ V. } I_S = -0.8 \text{ A} \text{ (Note 2)}$          | P-Ch | -0.79 | -1.2 |   |  |

#### Notes:

1: R<sub>e,JA</sub> is the sum of the junction-to-case and case-to-ambient resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.

R<sub>e,JC</sub> is guaranteed by design while R<sub>e,JA</sub> is determined by the user's board design. Both devices are assumed to be operating and sharing the dissipated heat energy equally.



a) 130 °C/W when mounted on a 0.125 in² pad of 2 oz. copper.



b) 140 °C/W when mounted on a 0.005 in² pad of 2 oz. copper.



c) 180 °C/W when mounted on a 0.0015 in² pad of 2 oz. copper.

Scale 1: 1 on letter size paper

2: Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2.0%

### **Typical Characteristics: N-Channel**

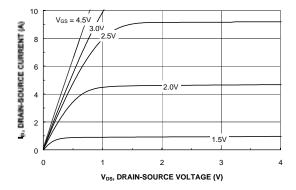


Figure 1. On-Region Characteristics.

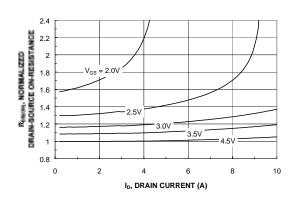


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

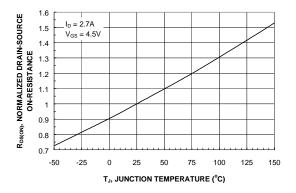


Figure 3. On-Resistance Variation with Temperature.

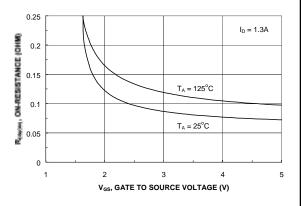


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

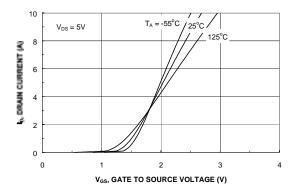


Figure 5. Transfer Characteristics.

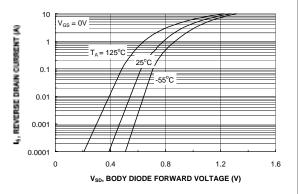
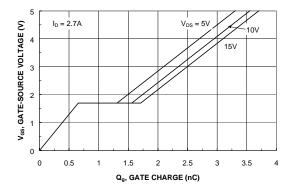


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

### **Typical Characteristics: N-Channel** (continued)



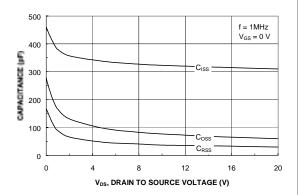
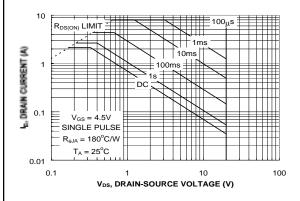


Figure 7. Gate-Charge Characteristics.

Figure 8. Capacitance Characteristics.



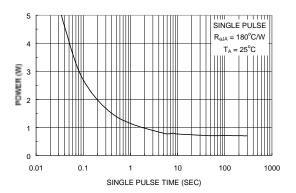
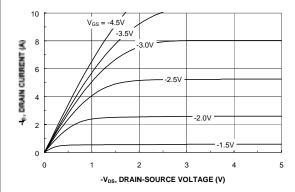


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

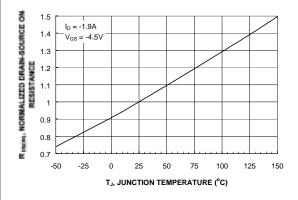
### **Typical Characteristics: P-Channel**



2.4 2.2 V<sub>GS</sub> = -2.0V -2.5V 1.6 1.4 1.2 1 0.8 0 2 4 6 8 10 -1<sub>0</sub>, DIRAIN CURRENT (A)

Figure 11. On-Region Characteristics.

Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.



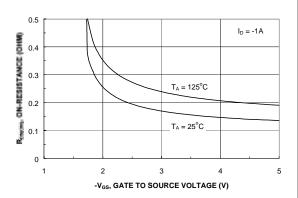
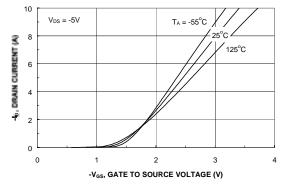


Figure 13. On-Resistance Variation with Temperature.

Figure 14. On-Resistance Variation with Gate-to-Source Voltage.



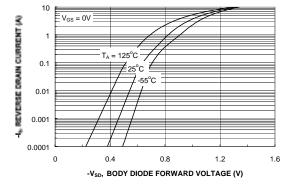
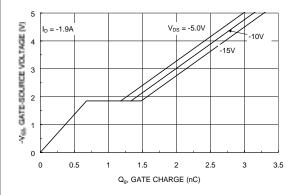


Figure 15. Transfer Characteristics.

Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

### **Typical Characteristics: P-Channel** (continued)



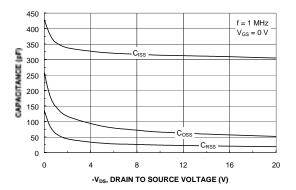
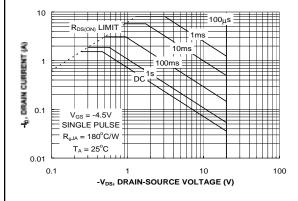


Figure 17. Gate-Charge Characteristics.

Figure 18. Capacitance Characteristics.



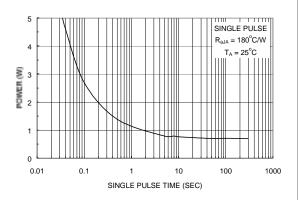


Figure 19. Maximum Safe Operating Area.

Figure 20. Single Pulse Maximum Power Dissipation.

### Typical Characteristics: N & P-Channel (continued)

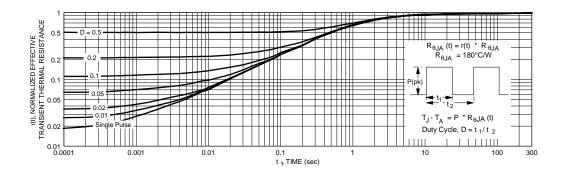


Figure 21. Transient Thermal Response Curve.

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